

FORM PTO-892		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		SERIAL NO. <b>09/608159</b>	GROUP ART UNIT <b>2185</b>	ATTACHMENT TO PAPER NO.	<b>5</b>
<b>NOTICE OF REFERENCES CITED</b>				APPLICANT(S)  <b>Wilcox et al.</b>			
<b>U.S. PATENT DOCUMENTS</b>							
*		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	A	5,329,471	7/1994	Swoboda et al.	395	500.44	
	B	5,471,587	11/1995	Fernando	710	129	
	C	5,577,192	11/1996	Niederer et al.	395	507	
	D	5,596,756	1/1997	O'Brien	713	340	
	E	5,623,673	4/1997	Gephardt et al.	710	260	
	F	5,640,573	6/1997	Gephardt et al.	713	340	
	G	5,884,023	3/1999	Swoboda et al.	714	30	
	H	5,915,107	6/1999	Maley et al.	713	400	
	I	5,958,011	9/1999	Arimilli et al.	709	224	
	J	6,047,382	4/2000	Maley et al.	713	501	
	K	6,049,887	4/2000	Khandekar et al.	713	503	
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*		DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUB- CLASS
	L	357100758A	6/1982	Japan	Chiba		
	M	401166241A	6/1989	Japan	Sagesaka et al.		
	N	402253738A	10/1990	Japan	Ueda et al.		
	O						
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<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
	R	MacKenzie et al., "A Separation Between Reconfigurable Mesh Models", IEEE 1993, pages 84-88.					
	S	Kim et al., "Impact of Cross-over Liners on Delay Time of Two Parallel Global Wires", IEEE 1999, pages 53-56.					
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EXAMINER <b>Chun Cao</b>			DATE <b>March 31, 2003</b>				
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* A copy of this reference is not being furnished with this office action. (See Manual of Patent Examining Procedure, section 707.05(a).)							

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<b>U.S. PATENT DOCUMENTS</b>							
*		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
	A	6,112,307	8/2000	Ajanovic et al.	713	400	
	B	6,349,392	2/2002	Swoboda et al.	714	30	
	C	6,522,985	2/2003	Swoboda et al.	702	117	
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